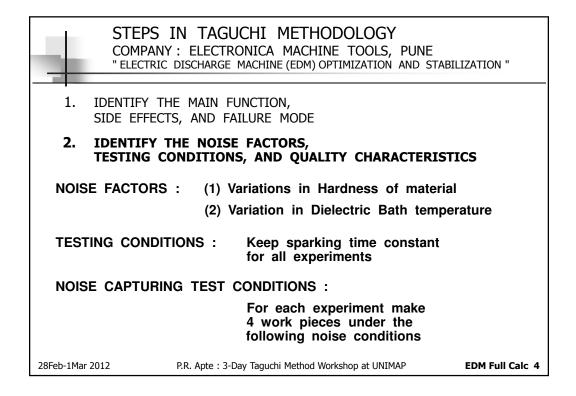
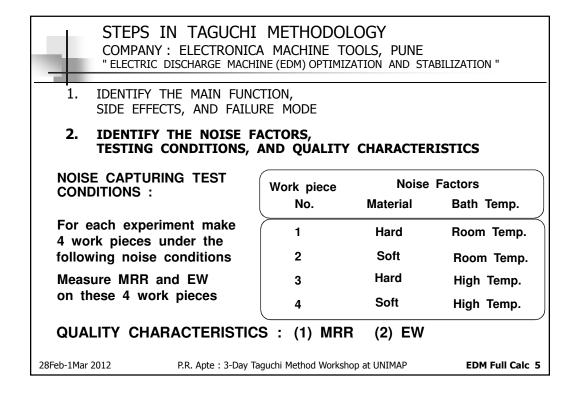
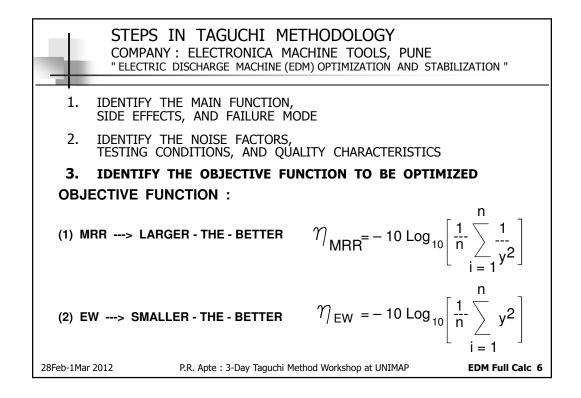
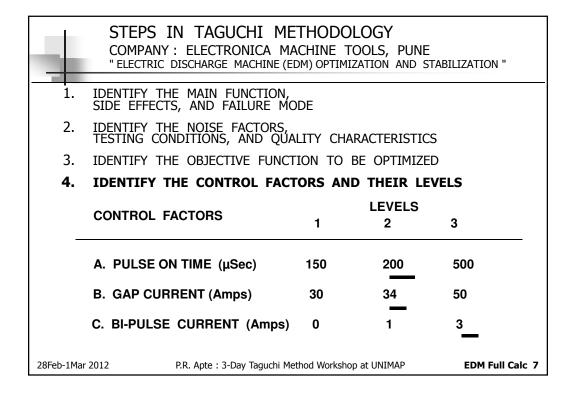


COMPANY :	TAGUCHI METHODOLOGY ELECTRONICA MACHINE TOOLS, PUNE CHARGE MACHINE (EDM) OPTIMIZATION AND STABILIZATION '	
	HE MAIN FUNCTION, TS, AND FAILURE MODE	
MAIN FUNCTION	: (1) Optimize and Stabilize the EDI Performance Characteristics na a. Material Removal Rate (MRF b. Percent Electrode Wear (EW	imely R)
SIDE EFFECTS :	Since this first trial application no Quality Characteristics will be obs	
FAILURE MODE	: Control Factor Levels are selected there will not be any failure durin experimentation leading to abortin experiment	g
28Feb-1Mar 2012	P.R. Apte : 3-Day Taguchi Method Workshop at UNIMAP	EDM Full Calc 3

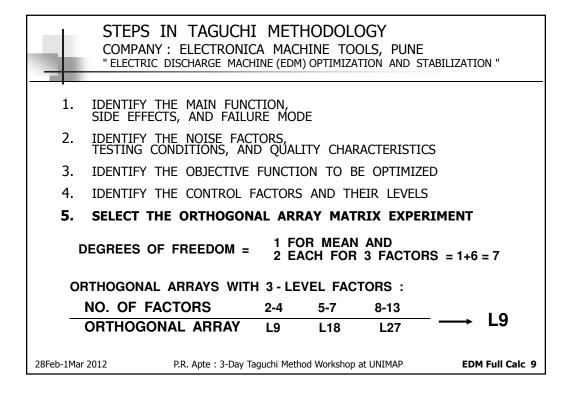


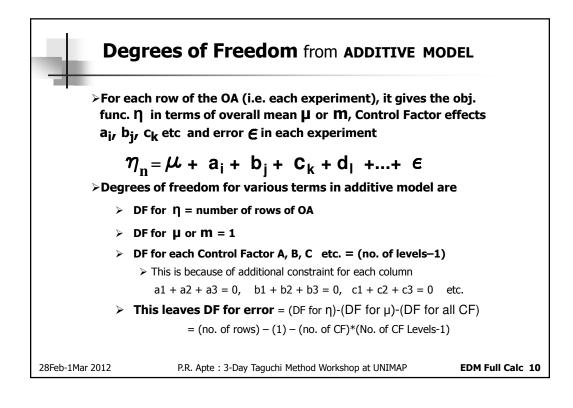


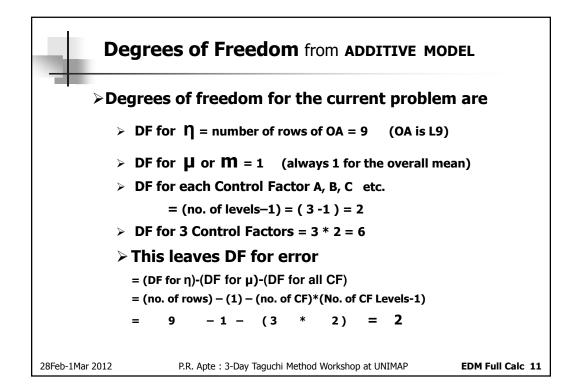




		LEVELS	
CONTROL FACTORS	1	2	3
Pulse-On Time	150 usec	200 usec	500 usec
Gap Current	30 amp	34 amp	50 amp
Bi-Pulse Current	0 amp	1 amp	3 amp
e	е	е	е

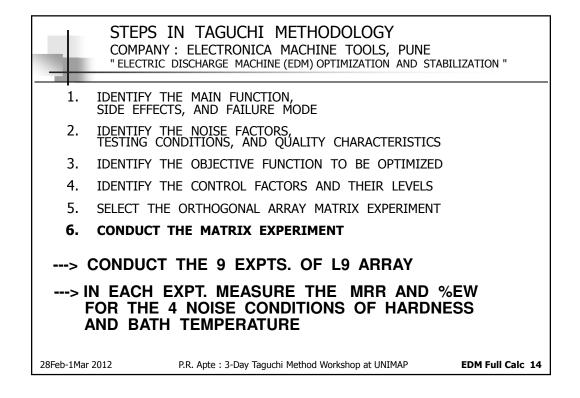






STEPS IN TAGUC COMPANY : ELECTRON "ELECTRIC DISCHARGE MA	IICA	MACH	INE	TOOLS	5, PUNE
5. SELECT THE ORTHOGO	NAL A	RRA	MA	FRIX	EXPERIMENT
L9 ORTH	IOG	ON	AL /	ARR	AY
EXPT. NO.	A 1	В 2	C 3	4	
1	A1	B1	C1	-	
2	A1	B2	C2	-	
3	A 1	B3	C3	-	
4	A2	B1	C2	-	
5	A2	B2	C3	-	
6	A2	B3	C1	-	
7	A3	B1	C3	-	
8	A3	B2	C1	-	
9	A3	B 3	C2	-	
28Feb-1Mar 2012 P.R. Apte : 3-Day	/ Tagucł	ni Metho	d Works	shop at U	INIMAP EDM Full Calc 12

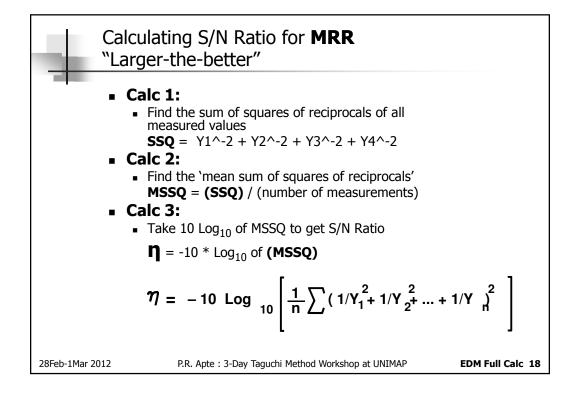
	Control Factors Assigned to columns									
Expt. No.	Pulse-On Time	Gap Current	Bi-Pulse Current	е						
1	150 usec	30 amp	0 amp	е						
2	150 usec	34 amp	1 amp	е						
3	150 usec	50 amp	3 amp	e						
4	200 usec	30 amp	1 amp	е						
5	200 usec	34 amp	3 amp	е						
6	200 usec	50 amp	0 amp	е						
7	500 usec	30 amp	3 amp	е						
8	500 usec	34 amp	0 amp	е						
9	500 usec	50 amp	1 amp	e						



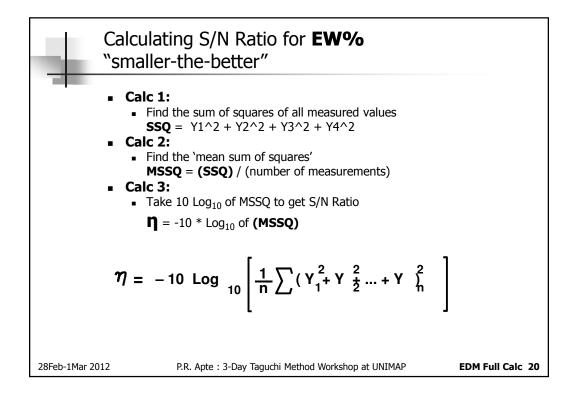
DATA f	or Qua	lity Chara	cteristic	cs, MRR	
Expt No.	4 Repetit	ions or Measur	ements for ea	ach expt.	
1	168.3	169.2	161.2	161.1	
2	221.4	220.5	214.2	215.3	
3	318.3	317.7	312.4	310.9	
4	192.4	191.5	188.7	187.1	
5	238.2	239.7	233.9	231.6	
6	312.6	311.2	307.3	308	
7	198.4	197.1	192.8	191.9	
8	181.1	182.3	178.9	177.4	
9	325.8	324.4	317.8	316.3	

DATA f	or Quali	ty Chara	cteristics	5, EW%
Expt No.	4 Repetit	ions or Measu	rements for ea	ich expt.
1	15.2	16.5	12.2	11.6
2	7.2	7.4	6.4	6.6
3	11.2	11.3	10.6	10.9
4	2.6	2.6	2.3	2.5
5	4.2	4.3	3.8	3.7
6	15.3	15.4	14.9	15.2
7	0.65	0.7	0.5	0.6
8	7.3	7.2	6.8	6.8
9	2	1.9	1.5	1.4

C	OMPANY : EI	LECTRONICA	METHODOLO MACHINE TOO NE (EDM) OPTIMIZA	OLS, PUN		TION "
6. CO	NDUCT THE	MATRIX	EXPERIMENT			
L9	ORTHOGONA	AL ARRAY A		NTER'S L	LOG	
					S / N	RATIO
EXPT. NO.	PULSE ON TIME A	GAP CURRENT B	BIPULSE CURRENT C	empty D	η MRR	η EW
1	150	30	0	-		
2	150	34	1	-		
3	150	50	3	-		
4	200	30	1	-		
5	200	34	3	-		
6	200	50	0	-		
7	500	30	3	-		
8	500	34	0	-		
9	500	50	1	-		
eb-1Mar 2012	P.R.	ı Apte : 3-Day Tagu	ı chi Method Workshop a	at UNIMAP	ED	M Full Calc

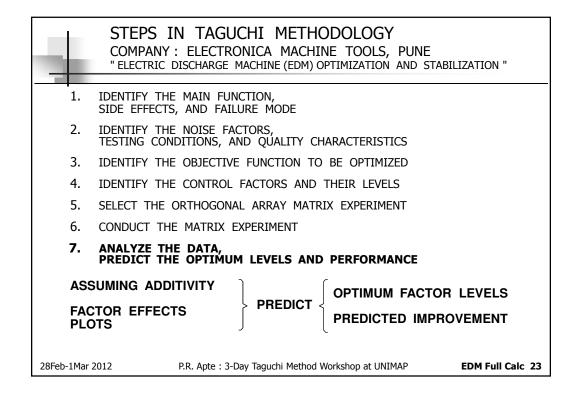


	Calculating S/N Ratio for MRR "Larger-the-better"											
-	Expt. No.	MRR1 H1 T1	MRR2 H1 T2	MRR3 H2 T1	MRR4 H2 T2	Sum of Squares of reciprocals	Mean of Sum of Squares of reciprocals	SN Ratio (Larger- the-Better)				
	1	168.3	169.2	161.2	161.1	1.47E-04	3.68E-05	44.34				
	2	221.4	220.5	214.2	215.3	8.43E-05	2.11E-05	46.76				
	3	318.3	317.7	312.4	310.9	4.04E-05	1.01E-05	49.96				
	4	192.4	191.5	188.7	187.1	1.11E-04	2.77E-05	45.57				
	5	238.2	239.7	233.9	231.6	7.20E-05	1.80E-05	47.45				
	6	312.6	311.2	307.3	308	4.17E-05	1.04E-05	49.82				
	7	198.4	197.1	192.8	191.9	1.05E-04	2.63E-05	45.80				
	8	181.1	182.3	178.9	177.4	1.24E-04	3.09E-05	45.10				
	9	325.8	324.4	317.8	316.3	3.88E-05	9.71E-06	50.13				
28Feb-1	LMar 2012		P.R. A	pte : 3-Day	/ Taguchi N	1ethod Workshop	at UNIMAP	EDM Full Calc	19			

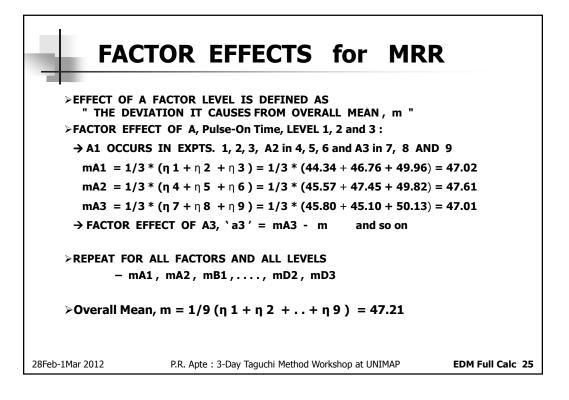


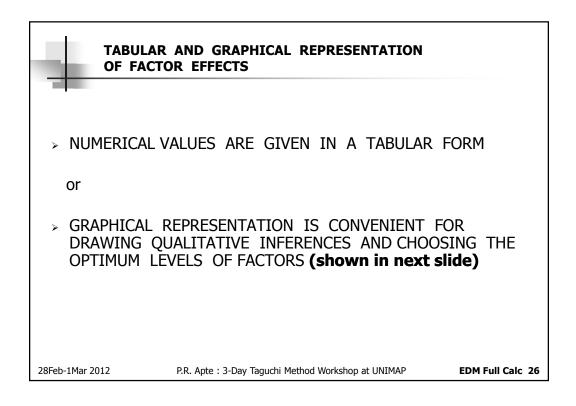
			-bette		• EW%		
Expt. No.	MRR1 H1 T1	MRR2 H1 T2	MRR3 H2 T1	MRR4 H2 T2	Sum of Squares	Mean of Sum of Squares	SN Ratio (smaller-the- better)
1	15.2	16.5	12.2	11.6	786.69	1.97E+02	-22.94
2	7.2	7.4	6.4	6.6	191.12	4.78E+01	-16.79
3	11.2	11.3	10.6	10.9	484.30	1.21E+02	-20.83
4	2.6	2.6	2.3	2.5	25.06	6.27E+00	-7.97
5	4.2	4.3	3.8	3.7	64.26	1.61E+01	-12.06
6	15.3	15.4	14.9	15.2	924.30	2.31E+02	-23.64
7	0.65	0.7	0.5	0.6	1.52	3.81E-01	4.20
8	7.3	7.2	6.8	6.8	197.61	4.94E+01	-16.94
9	2	1.9	1.5	1.4	11.82	2.96E+00	-4.71

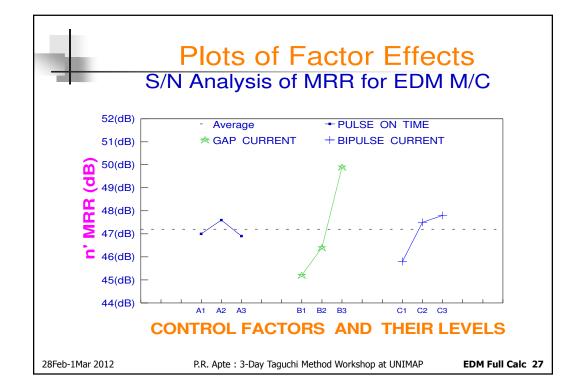
		AND %EW			
PULSE	GAP	BIPULSE		S/N F	RATIO
ON TIME A	CURRENT B	CURRENT C	empty D	MRR	%EW
150	30	0	-	44.34	-22.93
150	34	1	-	46.76	-16.78
150	50	3	-	49.96	-20.83
200	30	1	-	45.57	-7.96
200	34	3	-	47.45	-12.05
200	50	0	-	49.82	-23.63
500	30	3	-	45.80	4.43
500	34	0	-	45.10	-16.91
500	50	1	-	50.13	-4.62
	S/N Ratios PULSE ON TIME A 150 150 200 200 200 200 500 500	PULSE ON TIME A GAP CURRENT B 150 30 150 34 150 50 200 30 200 30 200 30 200 30 500 30 500 30 500 30 500 34	S/N Ratios for MRR AND %EW PULSE ON TIME A GAP CURRENT B BIPULSE CURRENT C 150 30 0 150 34 1 150 50 3 200 30 1 200 30 0 500 34 3 500 30 3 500 34 0	S/N Ratios for MRR AND %EW PULSE ON TIME A GAP CURRENT B BIPULSE CURRENT C empty D 150 30 0 - 150 34 1 - 150 34 1 - 200 30 1 - 200 30 1 - 200 30 1 - 200 30 1 - 200 30 1 - 200 30 3 - 200 34 3 - 500 30 3 - 500 34 0 -	S/N Ratios for MRR AND %EW PULSE ON TIME A GAP CURRENT B BIPULSE CURRENT C empty D S/N F 150 30 0 - 44.34 150 34 1 - 46.76 150 50 3 - 49.96 200 30 1 - 45.57 200 34 3 - 47.45 200 50 0 - 49.82 500 30 3 - 45.80 500 34 0 - 45.10



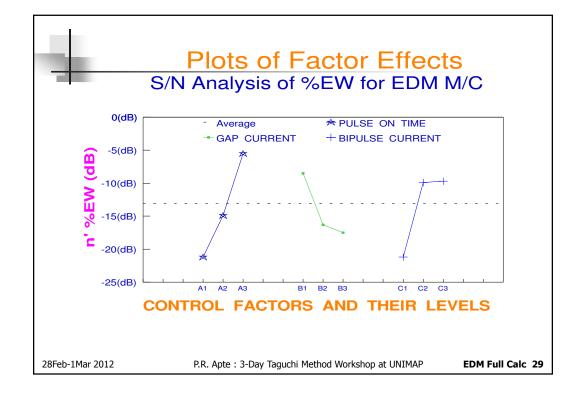
EXPT. NO.	1 . A .	2 . B .	3 . C .	4 . D .	SN-RATIO ¶ (in dB)
1	A1	B1	C1	D1	η1
2	A1	B2	C2	D2	η2
3	A1	B3	C3	D3	η3
4	A2	B1	C2	D3	η4
5	A2	B2	C3	D1	η5
6	A2	B3	C1	D2	η6
7	A3	B1	C3	D2	η7
8	A3	B2	C1	D3	η8
9	A3	B3	C2	D1	η9

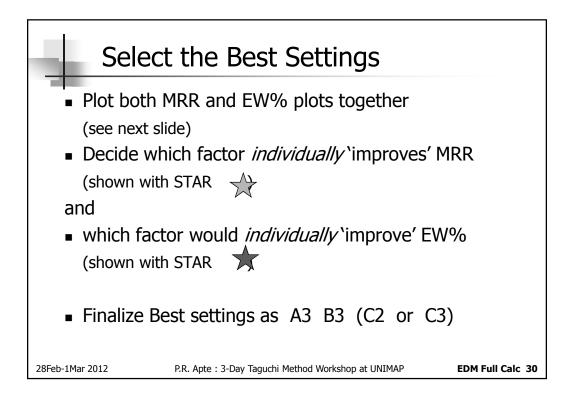


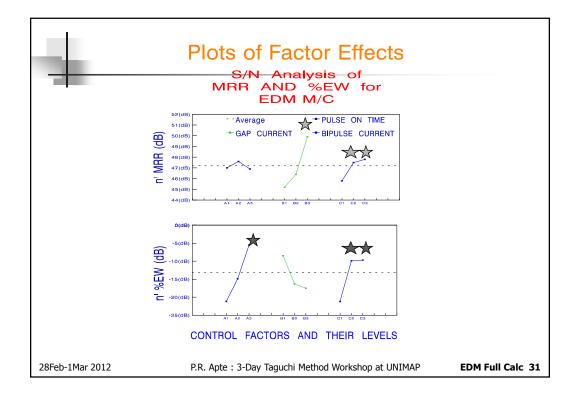


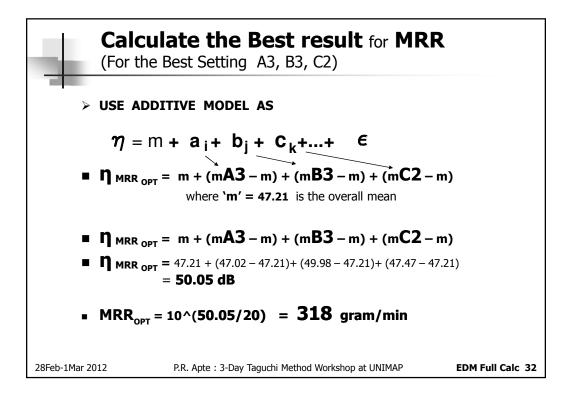


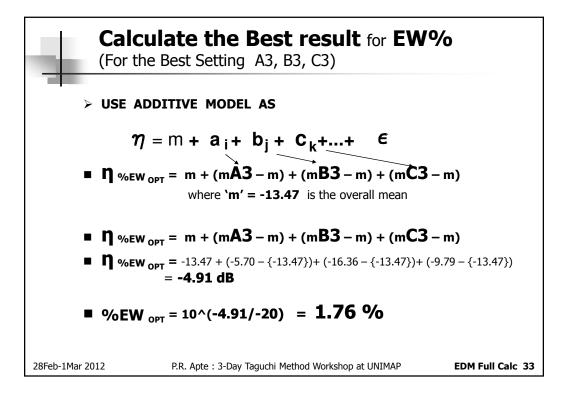
FAC	TOR	EFFECTS	for	EW%
" THE DE	VIATION 1	LEVEL IS DEFIN T CAUSES FROM	OVERALL	
			-	d A3 in 7, 8 AND 9
-	•••••	• • •	•	16.78 - 20.83) = -20.18
-	••	••••	•	12.05 – 23.63) = -14.54 16.91 – 4.62) = - 5.70
→ FACTOR	EFFECT OF	• A3, `a3 ′ = mA3	3 - m	and so on
		TORS AND ALL L , mB1,, mD		
· Overall Me	an, m = 1	/9 (η 1 + η 2 +	+η9)) = -13.47
28Feb-1Mar 2012	P.R. A	pte : 3-Day Taguchi Met	hod Worksho	p at UNIMAP EDM Full Calc 3











PREDICTION AND VERIFICATION MRR AND %EW for EDM Machine					
	CONTROL FACTOR SETTINGS	MRR(ccm / min)		%EW	
		PREDICTED	OBSERVED	PREDICTED	OBSERVED
NOMINAL	A2 B2 C2	233	236	4.13	4.0
OPTIMUM	A3 B3 C2	318	321	1.76	1.7
% IMPROVEMENT		39%	36%	57%	57%
28Feb-1Mar 2012 P.R. Apte : 3-Day Taguchi Method Workshop at UNIMAP EDM Full Cale					

